Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination MCINTYRE, KRISTEN A.	
09/934,776		
Examiner	Art Unit	
Wenpeng Chen	2624	

SEARCHED					
Class	Subclass	Date	Examiner		
382	239 7				
	240	)			
709	233	/			
370	229 ]/				
above	updated	6/23/2005	me		
			,		
			_		
٠					
*					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			
·	<u></u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout.	6/22/05 6/24/05	me		
IEEE Xplore - See search result printout.	6/13/5	ane		